# 3M<sup>™</sup> Three-Wall Header 3000 Series 3M<sup>™</sup> Four-Wall Header 3000 Series 3M<sup>™</sup> Three-Wall Condo Header 3000 Series 3M<sup>™</sup> Four-Wall Condo Header 3000 Series

Product Specification 78-5102-0008-0

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#### 1. Scope

This document summarizes test methods, test conditions and product performance requirements for the 3M<sup>™</sup> Three-Wall and Four-Wall Headers 3000 Series. Listings of materials, finishes, test conditions, and test standards are included in this specification. In the event of conflict between this specification and any documents listed below, the listed documentation supersedes this specification.

## 2. 3M Documents

78-5100-0771-5	TS-0771, Technical Data Sheet for 3M™ Three-Wall Header, N3000 Series
78-5100-0772-3	TS-0772, Technical Data Sheet for 3M™ Four-Wall Header, N3000 and D3000
78-5100-0773-1	TS-0773, Technical Data Sheet for 3M™ Three-Wall Condo Header, N3000 Series
78-5100-0774-9	TS-0774, Technical Data Sheet for 3M™ Four-Wall Condo Header, N3000 Series
78-9100-7795-3	Instructions for 3M™ Polarizing Key, 3518

#### 3. Performance and Test Description

Unless otherwise specified, all tests shall be performed on the 3M<sup>™</sup> Four-Wall Header, N3000 Series, part number N3433-XXXXRB or N3372-XXXXRB with 30µ" of gold mated to 3M<sup>™</sup> Wiremount Socket, 3000 Series, part number 3425-XXXX or 3334-XXXX sockets with 30µ" of gold using 3M<sup>™</sup> Round Conductor Flat Cable, 3365 Series and 3M<sup>™</sup> Round Conductor Flat Cable, 3801 Series at ambient environmental conditions per EIA-364. Unless otherwise specified, all values and limits are typical of those obtained by qualification testing of the subject product. All specifications are subject to revision and change without notice.

## 4. Requirements Overview

#### 4.1 Ratings

Dielectric Withstanding Voltage: 500  $\mathsf{VAC}_\mathsf{RMS}$  at sea level

Current: (EIA-364-070 method 2, 30°C maximum temperature rise.)

1 Line6\* LinesAll Lines5.003.001.75\*Lines are adjacent in 2x3 configuration

Temperature: -55°C to +105°C

Insulation Resistance: >1  $x10^{9}\Omega$  at 500 VDC UL Rating: 1.0A, 250V, 130C

#### 4.2 Materials

Insulation: Glass Filled PCT, High Temperature Option Contact: Copper Alloy

#### 4.3 Finishes

Plating:

TS-0771, TS-0772, TS-0773, TS-0774

10 0111, 10 0112, 10	5 0116, 16 0114
Overall, Nickel:	50 - 150 μ inches, ASTM B689-97, SAE AMS-QQ-N-290
Wipe, Gold:	30 µ inches Avg, MIL-G-45204 Type II, Grade C, ASTM B488-01 (N3XXX-XXXRB)
	10 μ inches Avg, MIL-G-45204 Type II, Grade C, ASTM B488-01 (D3XXX-XXXXAR)
Tail:	200-300 μ inches Matte Tin (N3XXX-XXXRB)
	40-120 μ inches Matte Tin (D3XXX-XXXAR)
	Flash Gold (3XXX-XX05EB)
TS-0478 (Compliant	Pin)
Overall, Nickel:	50 - 150 μ inches, ASTM B689-97, SAE AMS-QQ-N-290
Wipe, Gold:	30 µ inches Avg, MIL-G-45204 Type II, Grade C, ASTM B488-01 (N3XXX-XXXRB)
Tail, Matte Tin:	200-300 μ inches Matte Tin (N3XXX-XXXRB)

#### 4.4 Regulatory Compliance

For regulatory information about this product, visit 3M.com/regs or contact your 3M representative.

Description or Values & Parameter Limits		Units	Requirement or Conditions	Test Standard or Method	
Dielectric Withstanding Voltage	1000	VAC <sub>RMS</sub>	AC <sub>RMS</sub> Measured between adjacent and opposing contacts. No disruptive discharge during 1 minute duration. Sea level with 70% relative humidity. Excludes cable.		
Dielectric Breakdown Voltage	1000	VAC/sec Ramp assembled pair at 500V/s until electrical arc. Sea level		EIA-364-20F Method A Test Condition I	
Insulation Resistance	>1x10 <sup>9</sup>	Ohms	Mated connectors. Measured between adjacent and opposing contacts. 500 VDC for 1 minute duration.	EIA-364-21F	
			3M 2560-6002-UB HDR mated to board mount socket connector. Same pin design and wipe plating as 3000 Series	FIA 004 70A	
Current Rating	5.00	Amperes	1 line driven. 30°C temp. rise. 20% derated.	EIA-364-70A Method 2	
	3.00		6 line driven. 30°C temp. rise. 20% derated.		
	1.75	<u> </u>	All line driven. 30°C temp. rise. 20% derated.		
Low Level Connection Resistance	<10	Milliohms	10 milliohm maximum $\Delta R$ contact resistance per mated interface throughout testing.	EIA-364-23C	

#### 6. Mechanical

Description or Values & Units Values & Values & Units		Units	Requirement or Conditions	Test Standard or Method	
Header Pin Retention / >15		Ν	Force / contact required to remove pin from header body.	EIA-364-29B	
Vibration	50-2000 5.35	Hz g	1.5 hours X, Y, & Z axis. Mated connector shall exhibit no discontinuities greater than 10 ns and 10 milliohm maximum $\Delta R$ contact resistance throughout testing.	EIA-364-28F Condition V, Table 2 Condition A, 1.5 hrs	
Physical Shock	50	g	3 Shocks each directions for X, Y, & Z axis. 18 total. Mated connector shall exhibit no discontinuities greater than 10 ns and 10 milliohm maximum $\Delta R$ contact resistance throughout testing.	EIA-364-27B Test Cond. C	
Durability (with Environmental)	50 (30μ" Au) 10 (10u" Au)		10 milliohm maximum $\triangle R$ contact resistance per mated interface throughout testing.	EIA-364-09C	

## 7. Physical

Description or Parameter	Values & Limits	Units	Requirement or Conditions	Test Standard or Method	
Visual	NA	NA	No defects such as deformation, blister, damage, crack, etc.	EIA-364-18A	
(Metallic Coating) Adhesion NA NA		NA	No cracking, flaking.	MIL-G-45204 Section 4.6.2	
Header Plating thickness Nickel (RB, AR, EB)) Gold Wipe (RB & EB) Gold Wipe (AR) Tin Tail (RB) Tin Tail (AR) Gold Tail (EB)	50-150 30 Avg 10 Avg 200-300 40-120 Flash	μ"	Average of random measurements from any 3 lots.	EIA-364-48 (A)	
Header Solderability, Lead-Free Dip Test	>95	Percent	Coverage of solderable area.	EIA-364-52 (A) Category 3	

## 8. Environmental

Description or Parameter	Values & Limits	Units	Requirement or Conditions	Test Standard or Method	
Temperature Life	1000 105	hours °C	No physical abnormalities . 10 milliohm maximum $\Delta R$ contact resistance per mated interface throughout testing.	EIA-364-17C Method A Condition 4	
Humidity Temperature Cycling	10 +25 to +65 80 to 100 -10	Days °C % RH °C cold shock	$^{\circ}C$ maximum $\Delta R$ contact resistance per mated interface throughout testing		
		No physical abnormalities. 10 milliohm maximum $\Delta R$ contact resistance per mated interface throughout testing.	EIA-364-32G Method A, Test Cond. VII		
5% NaCl hours10 milliohm maximum ∆R contact throughout testing.		10 milliohm maximum $\Delta R$ contact resistance per mated interface throughout testing.	EIA-364-26C Test Cond. B		
Moisture Sensitivity Level	vel 260 °C	•	Level 1 (85°C / 85% RH, 168 hours), 1 Reflow. No defects such as deformation, blister, damage, crack, etc., must maintain	J-STD-020E	
(Header)	1 Cycle	Reflow Cycles	dimensional stability.	Level 1 (MSL1)	

## 9. Test Sequence

9.1 Sequenced Tests		TEST FLOW	V				
TEST	EIA 364	TEST GROUP & TEST SEQUENCE					
1231	TP NO.	Α	В	С	D	Е	F
Visual	18	0,8	0,5	0,6	0,6	0,6	0,3
LLCR	23	1,3,5,7	1,3	1,3,5	1,3,5		
Durability (Full)	13	2			2	3	
Temperature Life (Full)	17		2				
Mechanical Shock	27			2			
Vibration	28			4			
Thermal Shock	32	4					
Humidity Temperature Cycling	31	6					
Salt Spray	26				4		
Dielectric Withstanding Voltage	20					1,4	2
Dielectric Breakdown Voltage	20					7	
Insulation Resistance	21					2,5	
Contact Wiper Normal Force	4		4				
Temperature Rise vs. Current	70						1

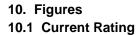
#### 9.2 Independent Tests

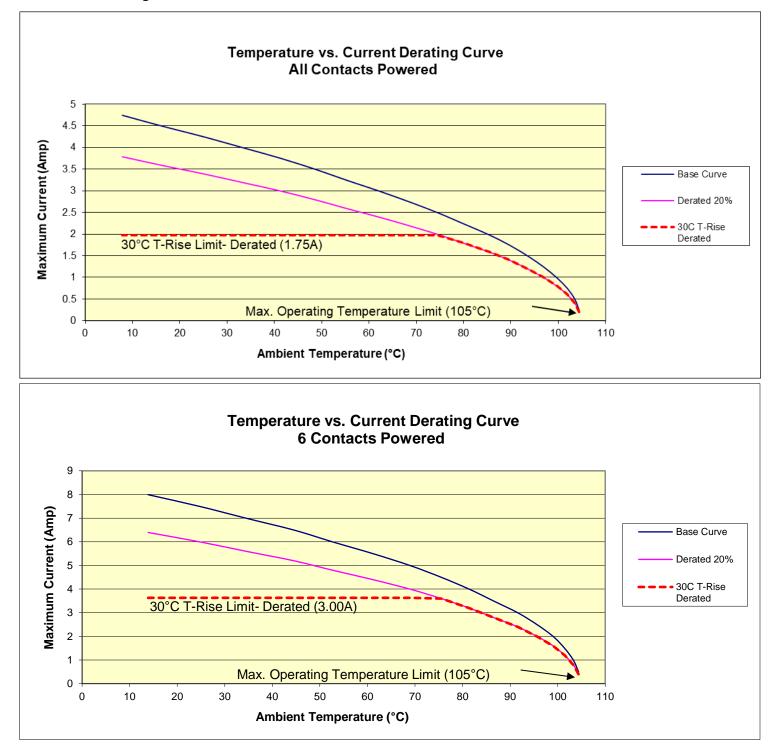
1. Contact Retention

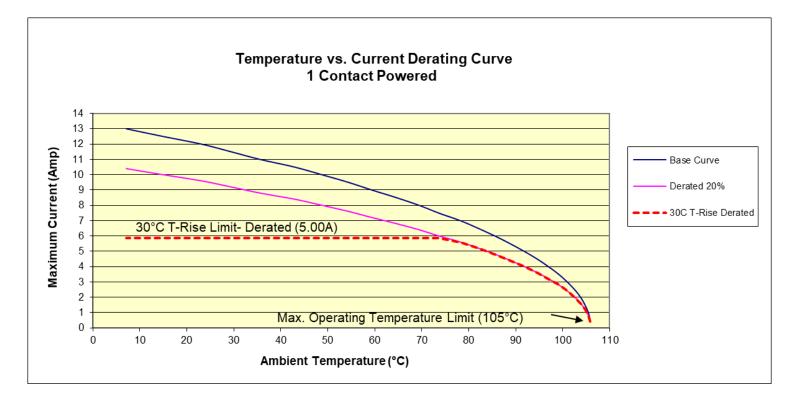
2. (Metal Coating) Adhesion

3. Moisture Sensitivity Level

4. Header Solderability







## 11. Agency Listings

11.1 Underwriters Laboratories (UL)

Agency	File No.
UL	E68080
CUL	E68080

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Unless otherwise noted, references to industry specifications are intended to indicate substantial compliance to the material elements of the specification. Such references should not be construed as a guarantee of compliance to all requirements in a given specification.

Regulatory: For regulatory information about this product, visit 3M.com/regs

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